Power MOSFET 40 V, 1.4 mΩ, 200 A, Single N–Channel

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- LFPAK8 Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Paran	Parameter Symbol Value Unit				
Drain-to-Source Voltage		V _{DSS}	40	V	
Gate-to-Source Voltage	e		V _{GS}	±20	V
Continuous Drain Current R _{θJC}	Steady State	$T_{\rm C} = 25^{\circ}{\rm C}$	۱ _D	200	А
(Notes 1, 3)	olulo	$T_{C} = 100^{\circ}C$		140	
Power Dissipation		$T_{C} = 25^{\circ}C$	PD	110	W
R _{θJC} (Note 1)		$T_{\rm C} = 100^{\circ}{\rm C}$		53	
Continuous Drain Current R _{θJA}	Steady State	$T_A = 25^{\circ}C$	Ι _D	38	А
(Notes 1, 2, 3)	Sidle	T _A = 100°C		27	
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.8	W
R _{θJA} (Notes 1 & 2)		$T_A = 100^{\circ}C$		1.9	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	900	А
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to + 175	°C
Source Current (Body Diode)			۱ _S	120	А
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 15 A$)			E _{AS}	493	mJ
Single Pulse Drain–to–Source Voltage ($t_p = 10 \ \mu s$)			V _{DSM}	48	V
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	36	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

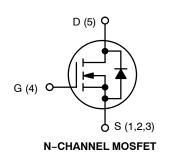
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

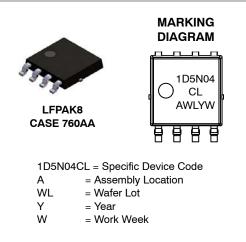


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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
40 V	1.4 mΩ @ 10 V	200 A	
	2.2 mΩ @ 4.5 V	200 A	





ORDERING INFORMATION

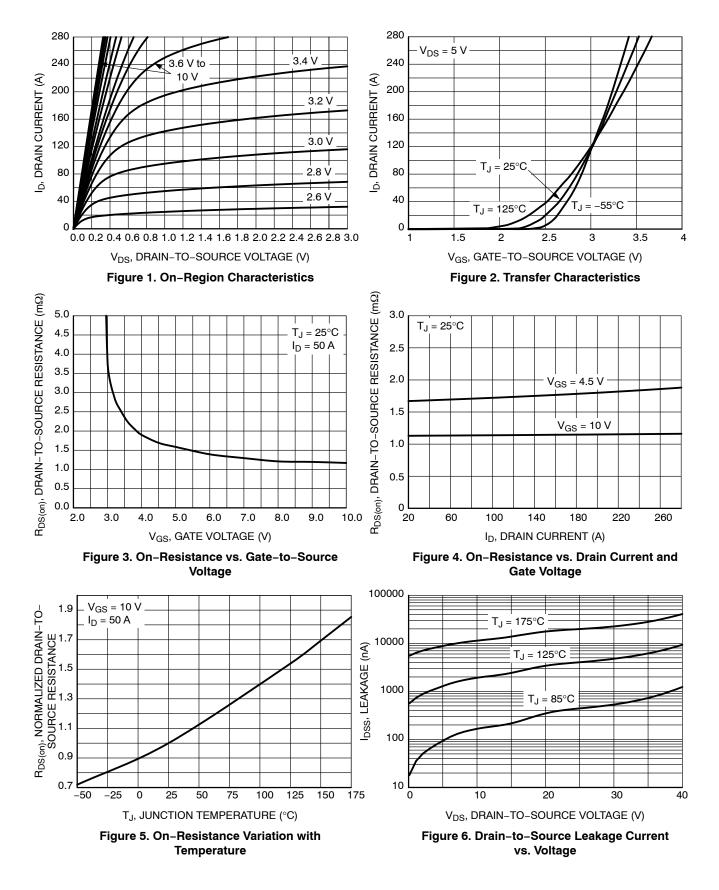
See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

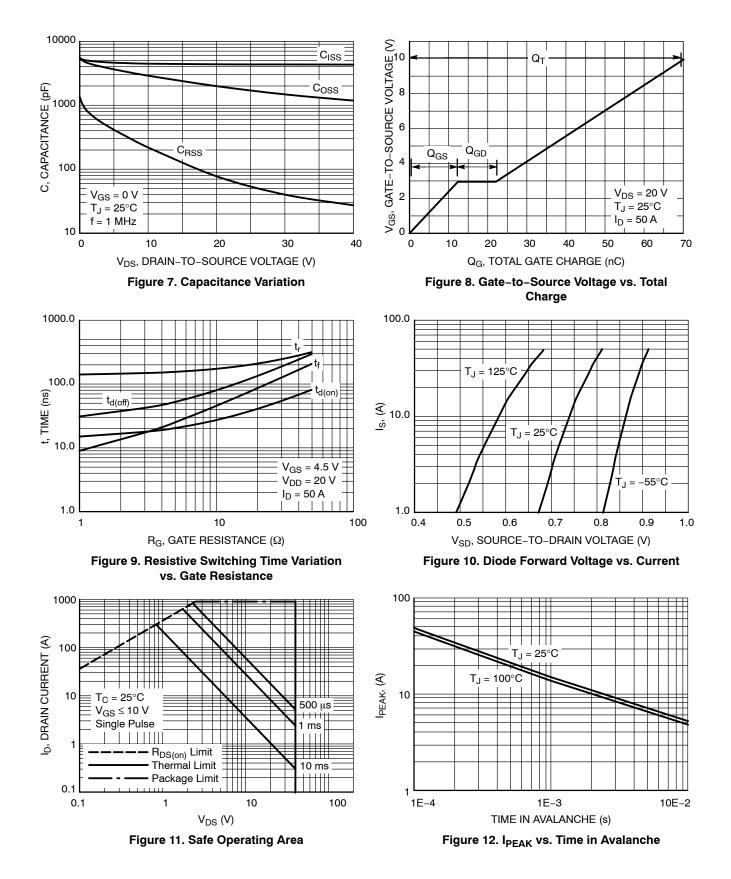
Parameter	Symbol	Test Conc	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 µA		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				2.0		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	T _J = 25 °C			10	μA
		V _{DS} = 40 V	T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D	= 130 μA	1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V	I _D = 50 A		1.7	2.2	mΩ
		V _{GS} = 10 V	I _D = 50 A		1.2	1.4	
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I	_D = 50 A		256		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 20 V			4300		pF
Output Capacitance	C _{OSS}				1900		
Reverse Transfer Capacitance	C _{RSS}				72		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 20 V; I_{D} = 50 A			32		nC
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 20 V; I_{D} = 50 A			70		
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 4.5 V, V_{DS} = 20 V; I_{D} = 50 A			7.0		
Gate-to-Source Charge	Q _{GS}				12		
Gate-to-Drain Charge	Q _{GD}				9.0		
Plateau Voltage	V _{GP}				2.9		V
SWITCHING CHARACTERISTICS (Note §	5)						
Turn-On Delay Time	t _{d(ON)}	V _{GS} = 4.5 V, V I _D = 50 A, R	_{DS} = 20 V,		15		ns
Rise Time	tr	I _D = 50 A, R	$_{\rm G} = 1 \Omega$		140		
Turn-Off Delay Time	t _{d(OFF)}				31		
Fall Time	t _f				9		
DRAIN-SOURCE DIODE CHARACTERIS	STICS			-		-	
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.81	1.2	V
		I _S = 50 A	T _J = 125°C		0.68		1
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dI _s /dt = 100 A/µs, I _S = 50 A			61		ns
Charge Time	ta				29		
Discharge Time	t _b				32		
Reverse Recovery Charge	Q _{RR}				80		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

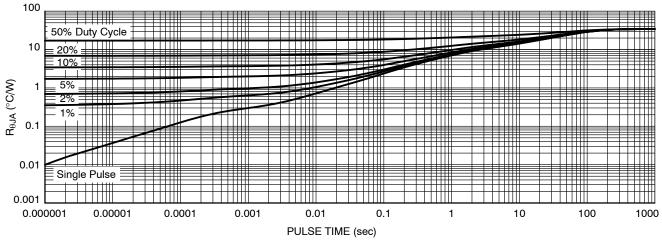


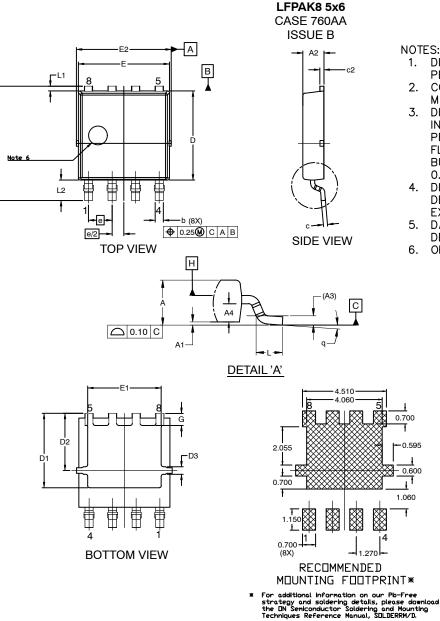
Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMJS1D5N04CLTWG	1D5N04CL	LFPAK8 (Pb–Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING
- PER ASME Y14.5M, 1994. CONTROLLING DIMENSION:
- MILLIMETERS. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- OPTIONAL MOLD FEATURE.

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	1.10	1.20	1.30			
A1	0.00	0.08	0.15			
A2	1.10	1.15	1.20			
A3	().25 REF				
A4	0.45	0.50	0.55			
b	0.40	0.45	0.50			
С	0.19	0.22	0.25			
c2	0.19	0.22	0.25			
D	4.70	4.80	4.90			
D1	-	-	4.20			
D2	3.00	3.10	3.20			
D3	0.30	0.40	0.50			
Е	4.80	4.90	5.00			
E1	3.90	4.00	4.10			
E2	5.00	5.15	5.30			
е		1.27 BSC				
G	0.55	0.65	0.75			
Н	6.00	6.15	6.30			
L	0.40	0.65	0.85			
L1	0.15	0.25	0.35			
L2	0.80	1.05	1.30			
q	0 °	4°	8 °			

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